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EFS ID: 54620
Application ID: 10679844



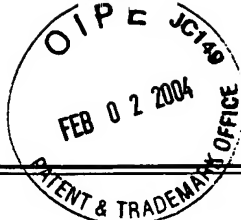
Title of Invention: METHODS AND SYSTEMS FOR
INSPECTING RETICLES USING
AERIAL IMAGING AT OFF-
STEPPER WAVELENGTHS

First Named Inventor: Stan Stokowski
Domestic/Foreign Application: Domestic Application
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Statement

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Confirmation number: 3733
Attorney Docket Number: 5589-04201

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Electronic Version v1.1

Stylesheet Version v1.1.0

Title of Invention	METHODS AND SYSTEMS FOR INSPECTING RETICLES USING AERIAL IMAGING AT OFF-STEPPER WAVELENGTHS									
Application Number: 10/679844 										
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<table border="1"><thead><tr><th>Submitted by:</th><th>Elec. Sign.</th><th>Sign. Capacity</th></tr></thead><tbody><tr><td>Kevin L. Daffer Registered Number: 34146</td><td>Kevin L. Daffer</td><td>Attorney</td></tr></tbody></table>			Submitted by:	Elec. Sign.	Sign. Capacity	Kevin L. Daffer Registered Number: 34146	Kevin L. Daffer	Attorney		
Submitted by:	Elec. Sign.	Sign. Capacity								
Kevin L. Daffer Registered Number: 34146	Kevin L. Daffer	Attorney								
<table><tr><td>Documents being submitted</td><td>Files</td></tr><tr><td>us-ids</td><td>558904001IDS-usidst.xml</td></tr><tr><td></td><td>us-ids.dtd</td></tr><tr><td></td><td>us-ids.xsl</td></tr></table>			Documents being submitted	Files	us-ids	558904001IDS-usidst.xml		us-ids.dtd		us-ids.xsl
Documents being submitted	Files									
us-ids	558904001IDS-usidst.xml									
	us-ids.dtd									
	us-ids.xsl									
Comments										

ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18
 Stylesheet Version v18.0



Title of
Invention

**METHODS AND SYSTEMS FOR INSPECTING RETICLES
 USING AERIAL IMAGING AT OFF-STEPPER
 WAVELENGTHS**

Application Number: 10/679844
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Search string: (5980187 or 5619548 or 6104835 or 6233719
 or 5991699 or 5689614 or 4247203 or 4347001
 or 4378159 or 4448532 or 4532650 or 4555798
 or 4579455 or 4633504 or 4641967 or 4758094
 or 4766324 or 4805123 or 4845558 or 4877326
 or 4926489 or 5189481 or 5563702 or 5572598
 or 5737072 or 5889593 or 6052478 or 6076465
 or 6122046 or 6137570 or 6141038 or 6175645
 or 6282309 or 6363166).pn.

US Patent Documents

Note: Applicant is not required to submit a paper copy of cited US Patent Documents

init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
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Signature

Examiner Name	Date